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Texas Instruments
ADS8484IBRGZT

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Datasheet of ADS8484IBRGZT - IC ADC 18BIT 1.25MSPS 48-VQFN

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**ADS8484** 

SLAS511-NOVEMBER 2007

# 18-BIT, 1.25-MSPS, PSEUDO-BIPOLAR, FULLY DIFFERENTIAL INPUT, MICROPOWER SAMPLING ANALOG-TO-DIGITAL CONVERTER WITH PARALLEL INTERFACE, REFERENCE

#### **FEATURES**

- 1.25-MHz Sample Rate
- ±1.5 LSB Typ, ±2.5 LSB Max INL
- +0.8/-0.6 LSB Typ, +1.5/-1 LSB Max DNL
- 18-Bit NMC Ensured Over Temperature
- ±0.5-mV Offset Error
- ±0.05-PPM/°C Offset Error Drift
- ±0.1 %FSR Gain Error
- ±0.5-PPM/°C Gain Error Drift
- 98.5dB SNR, -120db THD, 121dB SFDR
- Zero Latency
- Low Power: 235 mW Typ at 1.25 MSPS
- Pseudo-Bipolar Fully Differential Input Range:
   V<sub>ref</sub> to –V<sub>ref</sub>
- Onboard Reference with 6 PPM/°C Drift
- Onboard Reference Buffer
- High-Speed Parallel Interface
- Wide Digital Supply 2.7 V to 5.25 V
- 8-/16-/18-Bit Bus Transfer

#### • 48-Pin 7x7 QFN Package

#### **APPLICATIONS**

- Medical Instruments
- Optical Networking
- Transducer Interface
- High Accuracy Data Acquisition Systems
- Magnetometers

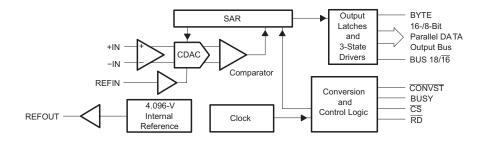
#### **DESCRIPTION**

The ADS8484 is an 18-bit, 1.25-MSPS A/C converter with an internal 4.096-V reference and a pseudo-bipolar, fully differential input. The device includes a 18-bit capacitor-based SAR A/D converter with inherent sample and hold. The ADS8484 offers a full 18-bit interface, a 16-bit option where data is read using two read cycles, or an 8-bit bus option using three read cycles.

The ADS8484 is available in a 48-lead 7x7 QFN package and is characterized over the industrial –40°C to 85°C temperature range.

#### HIGH SPEED SAR CONVERTER FAMILY

TYPE/SPEED	500 kHz	~600 kHz	750 kHz	1 MHz	1.25 MHz	2 MHz	3 MHz	4MHz
40 D' D D''	ADS8383	ADS8381		ADS8481				
18-Bit Pseudo-Diff		ADS8380 (s)						
18-Bit Pseudo-Bipolar, Fully Diff		ADS8382 (s)		ADS8482	ADS8484			
40 B' Beaute B''	ADS8327	ADS8370 (s)	ADS8371	ADS8471	ADS8401	ADS8411		
16-Bit Pseudo-Diff	ADS8328	ADS8472 (s)			ADS8405	ADS8410 (s)		
4C Dit Decorde Dineles Fully Diff				ADS8472	ADS8402	ADS8412		ADS8422
16-Bit Pseudo-Bipolar, Fully Diff					ADS8406	ADS8413 (s)		
14-Bit Pseudo-Diff					ADS7890 (s)		ADS7891	
12-Bit Pseudo-Diff				ADS7886				ADS7881





Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



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These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

#### ORDERING INFORMATION(1)

MODEL	MAXIMUM INTEGRAL LINEARITY (LSB)	MAXIMUM DIFFERENTIAL LINEARITY (LSB)	NO MISSING CODES RESOLUTION (BIT)	PACKAGE TYPE	PACKAGE DESIGNATOR	TEMPERATURE RANGE	ORDERING INFORMATION	TRANSPORT MEDIA QTY.
ADS8484I	. 4	1 to 12	18	7x7 48 Pin QFN	RGZ	-40°C to 85°C -	ADS8484IRGZT	Tape and reel 250
AD304041	±4 -1 to +2	-1 10 +2			NGZ		ADS8484IRGZR	Tape and reel 1000
ADC0404ID	.25	4 to 14 5	18	7x7 48 Pin	RGZ	400C to 050C	ADS8484IBRGZT	Tape and reel 250
ADS8484IB	DS8484IB ±2.5	−1 to +1.5	18	QFN	RGZ	-40°C to 85°C	ADS8484IBRGZR	Tape and reel 1000

<sup>(1)</sup> For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI website at www.ti.com.

## ABSOLUTE MAXIMUM RATINGS(1)

over operating free-air temperature range (unless otherwise noted)

			VALUE	UNIT
		+IN to AGND	-0.4 to +VA + 0.1	V
		-IN to AGND	-0.4 to +VA + 0.1	V
	Voltage	+VA to AGND	-0.3 to 7	V
		+VBD to BDGND	-0.3 to 7	V
		+VA to +VBD	-0.3 to 2.55	V
	Digital input voltage to BDGND		-0.3 to +VBD + 0.3	V
	Digital output voltage to BDGND		-0.3 to +VBD + 0.3	V
T <sub>A</sub>	Operating free-air temperature ra	ange	-40 to 85	°C
T <sub>stg</sub>	Storage temperature range		-65 to 150	°C
	Junction temperature (T <sub>J</sub> max)		150	°C
	OFN poekege	Power dissipation	$(T_{J}Max - T_{A})/\theta_{JA}$	
	QFN package	θ <sub>JA</sub> thermal impedance	22	°C/W
	Load town areturn coldering	Vapor phase (60 sec)	215	°C
	Lead temperature, soldering	Infrared (15 sec)	220	°C

<sup>(1)</sup> Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under recommended operating conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

Product Folder Link(s): ADS8484

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#### **SPECIFICATIONS**

 $T_A = -40$ °C to 85°C, +VA = 5 V, +VBD = 3 V or 5 V,  $V_{ref} = 4.096$  V,  $f_{SAMPLE} = 1.25$  MSPS (unless otherwise noted)

	PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
ANALO	G INPUT						
	Full-scale input voltage <sup>(1)</sup>		+IN - (-IN)	-V <sub>ref</sub>		V <sub>ref</sub>	V
	A book to input valtage		+IN	-0.2		V <sub>ref</sub> + 0.2	V
	Absolute input voltage		-IN	-0.2		V <sub>ref</sub> + 0.2	V
	Common-mode input range			(V <sub>ref</sub> )/2 - 0.2	(V <sub>ref</sub> )/2	$(V_{ref})/2 + 0.2$	V
	Input capacitance				65		pF
	Input leakage current				1		nA
SYSTEM	I PERFORMANCE						
	Resolution				18		Bits
		ADS8484I		18			D.,
	No missing codes	ADS8484IB		18			Bits
	1 (2)	ADS8484I		-4	±1.5	4	LSB
INL	Integral linearity (2)	ADS8484IB		-2.5	±1.5	2.5	(18 bit)
	<b>5</b> // 11/11 15	ADS8484I		-1	-0.6/0.8	2	LSB
DNL	Differential linearity	ADS8484IB		-1	-0.6/0.8	1.5	(18 bit)
	0% (4)	ADS8484I		-2	±1	2	.,
	Offset error <sup>(4)</sup>	ADS8484IB		-0.5	±0.1	0.5	mV
	Officet arrest to see a return drift	ADS8484I			±0.05		
	Offset error temperature drift	ADS8484IB			±0.05		ppm/°0
_	Gain error <sup>(4) (5)</sup>	ADS8484I	V <sub>ref</sub> = 4.096 V	-0.1	±0.035	0.1	%FS
E <sub>G</sub>	Gain error (*)	ADS8484IB	V <sub>ref</sub> = 4.096 V	-0.1	±0.035	0.1	%FS
	0-1	ADS8484I			±0.5		
	Gain error temperature drift	ADS8484IB			±0.5		ppm/°C
CMDD	Common mode valenties votic		At dc (±0.2 V around V <sub>ref</sub> /2)		60		40
CMRR	Common-mode rejection ratio		+IN - (-IN) = 1 Vpp at 1.25 MHz		55		dB
	Noise				30		μV RM
	Power supply rejection ratio		At 1FFFFh output code		60		dB
SAMPLI	NG DYNAMICS						
	Conversion time				575	610	ns
	Acquisition time			175	200		ns
	Throughput rate					1.25	MHz
	Aperture delay				4		ns
	Aperture jitter				5		ps
	Step response				150		ns
	Over voltage recovery				150		ns

- Ideal input span, does not include gain or offset error.
- (2) This is endpoint INL, not best fit.
- LSB means least significant bit
- Measured relative to an ideal full-scale input [+IN (-IN)] of 8.192 V
- This specification does not include the internal reference voltage error and drift.

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TEXAS INSTRUMENTS www.ti.com

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## **SPECIFICATIONS (Continued)**

 $T_A = -40^{\circ}\text{C}$  to 85°C, +VA = 5 V, +VBD = 3 V or 5 V,  $V_{ref} = 4.096$  V,  $f_{SAMPLE} = 1.25$  MSPS (unless otherwise noted)

	PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT	
DYNAN	IIC CHARACTERISTICS							
		ADS8484I	V 0V -+0H-		-115			
		ADS8484IB	$V_{IN} = 8 V_{pp}$ at 2 kHz		-120			
TUD	Total harmonic distortion (1)	ADS8484I	V 9.V at 20 kHz		-105		dB	
THD	Total narmonic distortion (*)	ADS8484IB	$V_{IN} = 8 V_{pp}$ at 20 kHz		-110		uв	
		ADS8484I	V 9.V -+ 400 kH=		-100			
		ADS8484IB	$V_{IN} = 8 V_{pp}$ at 100 kHz		-103			
		ADS8484I	V 0V -+0H-	96	97			
		ADS8484IB	$V_{IN} = 8 V_{pp}$ at 2 kHz	97	98.5		dB	
OND	SNR Signal-to-noise ratio (1)	ADS8484I	V - 0.V -+ 00.HI-		96			
SNR	Signal-to-noise ratio (1)	ADS8484IB	$V_{IN} = 8 V_{pp}$ at 20 kHz		98			
		ADS8484I	V 0.V -+ 400 H.I-		95			
		ADS8484IB	$V_{IN} = 8 V_{pp}$ at 100 kHz		97			
		ADS8484I	V 0V -+0H-	96	96		dB	
		ADS8484IB	$V_{IN} = 8 V_{pp} \text{ at } 2 \text{ kHz}$	97	98.5			
OINIAD	0:	ADS8484I	V 0.V -+ 00.HH-		95			
SINAD	Signal-to-noise + distortion (1)	ADS8484IB	$V_{IN} = 8 V_{pp}$ at 20 kHz		97			
		ADS8484I	V 0 V -+ 400 H I-		93			
		ADS8484IB	$V_{IN} = 8 V_{pp}$ at 100 kHz		95			
		ADS8484I	V 0V 1011		117			
		ADS8484IB	$V_{IN} = 8 V_{pp}$ at 2 kHz		121			
OEDE	0	ADS8484I	V 0.V -+ 00.HH-		107		-ID	
SFDR	Spurious free dynamic range (1)	ADS8484IB	$V_{IN} = 8 V_{pp}$ at 20 kHz		113		dB	
		ADS8484I	V 0 V -+ 400 H I-		102			
		ADS8484IB	$V_{IN} = 8 V_{pp}$ at 100 kHz		105			
	-3dB Small signal bandwidth				15		MHz	

<sup>(1)</sup> Calculated on the first nine harmonics of the input frequency.

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## **SPECIFICATIONS (Continued)**

 $T_{A} = -40^{\circ}\text{C to } 85^{\circ}\text{C}, \text{ +VA} = 5 \text{ V}, \text{ +VBD} = 3 \text{ V or 5 V}, V_{ref} = 4.096 \text{ V}, f_{SAMPLE} = 1.25 \text{ MSPS (unless otherwise noted)}$ 

	PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
VOLTA	AGE REFERENCE INPUT						
$V_{ref}$	Reference voltage at REF	IN		3.0	4.096	+VA - 0.8	V
	Reference resistance <sup>(1)</sup>				500		kΩ
	Reference current drain		f <sub>s</sub> = 1.25 MHz			1	mA
INTER	NAL REFERENCE OUTPUT						
	Internal reference start-up	time	From 95% (+VA), with 1-μF storage capacitor			120	ms
V <sub>ref</sub>	Reference voltage range		I <sub>O</sub> = 0	4.081	4.096	4.111	V
	Source current		Static load			10	μΑ
	Line regulation		+VA = 4.75 V ~ 5.25 V		60		μV
	Drift		I <sub>O</sub> = 0		±6		PPM/°C
DIGITA	AL INPUT/OUTPUT			-			
	Logic family – CMOS						
V <sub>IH</sub>	High-level input voltage		I <sub>IH</sub> = 5 μA	+VBD – 1		+VBD + 0.3	
V <sub>IL</sub>	Low-level input voltage		I <sub>IL</sub> = 5 μA	-0.3		0.8	V
V <sub>OH</sub>	High-level output voltage		I <sub>OH</sub> = 2 TTL loads	+VBD - 0.6			V
V <sub>OL</sub>	Low-level output voltage		I <sub>OL</sub> = 2 TTL loads			0.4	
	Data format – Two's Com	plement					
POWE	R SUPPLY REQUIREMENTS			-			
	Danier and the sec	+VBD		2.7	3.3	5.25	V
	Power supply voltage	+VA		4.75	5	5.25	V
	Supply current <sup>(2)</sup>		f <sub>s</sub> = 1.25 MHz		47	52	mA
	Power dissipation <sup>(2)</sup>		f <sub>s</sub> = 1.25 MHz		235	260	mW
TEMPE	ERATURE RANGE						
	Operating free-air			-40		85	°C

 <sup>(1)</sup> Can vary ±20%
 (2) This includes only +VA current. +VBD current is typical 1 mA with 5-pF load capacitance on all output pins.



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#### **TIMING CHARACTERISTICS**

All specifications typical at  $-40^{\circ}$ C to  $85^{\circ}$ C, +VA =+VBD = 5 V  $^{(1)}$   $^{(2)}$   $^{(3)}$ 

	PARAMETER	MIN	TYP	MAX	UNIT
t <sub>(CONV)</sub>	Conversion time			610	ns
t <sub>(ACQ)</sub>	Acquisition time	175			ns
t <sub>(HOLD)</sub>	Sample capacitor hold time			15	ns
t <sub>pd1</sub>	CONVST low to BUSY high			40	ns
t <sub>pd2</sub>	Propagation delay time, end of conversion to BUSY low			15	ns
t <sub>pd3</sub>	Propagation delay time, start of convert state to rising edge of BUSY			25	ns
t <sub>w1</sub>	Pulse duration, CONVST low	40			ns
t <sub>su1</sub>	Setup time, $\overline{\text{CS}}$ low to $\overline{\text{CONVST}}$ low	20			ns
t <sub>w2</sub>	Pulse duration, CONVST high	20			ns
	CONVST falling edge jitter			10	ps
t <sub>w3</sub>	Pulse duration, BUSY signal low	t <sub>(ACQ)</sub> min			ns
t <sub>w4</sub>	Pulse duration, BUSY signal high			610	ns
t <sub>h1</sub>	Hold time, first data bus transition (RD low, or CS low for read cycle, or BYTE or BUS18/16 input changes) after CONVST low	40			ns
t <sub>d1</sub>	Delay time, $\overline{\text{CS}}$ low to $\overline{\text{RD}}$ low	0			ns
t <sub>su2</sub>	Setup time, RD high to CS high	0			ns
t <sub>w5</sub>	Pulse duration, RD low	50			ns
t <sub>en</sub>	Enable time, $\overline{\text{RD}}$ low (or $\overline{\text{CS}}$ low for read cycle) to data valid			20	ns
t <sub>d2</sub>	Delay time, data hold from RD high	5			ns
t <sub>d3</sub>	Delay time, BUS18/16 or BYTE rising edge or falling edge to data valid	10		20	ns
t <sub>w6</sub>	Pulse duration, RD high	20			ns
t <sub>w7</sub>	Pulse duration, CS high	20			ns
t <sub>h2</sub>	Hold time, last $\overline{\text{RD}}$ (or $\overline{\text{CS}}$ for read cycle ) rising edge to $\overline{\text{CONVST}}$ falling edge	50			ns
t <sub>pd4</sub>	Propagation delay time, BUSY falling edge to next $\overline{\text{RD}}$ (or $\overline{\text{CS}}$ for read cycle) falling edge	0			ns
$t_{d4}$	Delay time, BYTE edge to BUS18/16 edge skew	0			ns
$t_{su3}$	Setup time, BYTE or BUS18/16 transition to RD falling edge	10			ns
t <sub>h3</sub>	Hold time, BYTE or BUS18/16 transition to RD falling edge	10			ns
t <sub>dis</sub>	Disable time, RD high (CS high for read cycle) to 3-stated data bus			20	ns
t <sub>d5</sub>	Delay time, BUSY low to MSB data valid delay			0	ns
$t_{d6}$	Delay time, CS rising edge to BUSY falling edge	50			ns
t <sub>d7</sub>	Delay time, BUSY falling edge to CS rising edge	50			ns
$t_{su5}$	BYTE transition setup time, from BYTE transition to next BYTE transition, or BUS18/ $\overline{16}$ transition setup time, from BUS18/ $\overline{16}$ to next BUS18/ $\overline{16}$ .	50			ns
t <sub>su(ABORT)</sub>	Setup time from the falling edge of $\overline{CONVST}$ (used to start the valid conversion) to the next falling edge of $\overline{CONVST}$ (when $\overline{CS}$ is used to abort) or to the next falling edge of $\overline{CS}$ (when $\overline{CS}$ is used to abort).	60		480	ns

- (1) All input signals are specified with t<sub>r</sub> = t<sub>f</sub> = 5 ns (10% to 90% of +VBD) and timed from a voltage level of (V<sub>IL</sub> + V<sub>IH</sub>)/2. (2) See timing diagrams.
- (2) (3) All timing are measured with 20-pF equivalent loads on all data bits and BUSY pins.



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#### **TIMING CHARACTERISTICS**

All specifications typical at  $-40^{\circ}$ C to  $85^{\circ}$ C, +VA = 5 V +VBD = 3 V  $^{(1)}$   $^{(2)}$   $^{(3)}$ 

	PARAMETER	MIN	TYP MAX	UNIT
t <sub>(CONV)</sub>	Conversion time		610	ns
t <sub>(ACQ)</sub>	Acquisition time	175		ns
t <sub>(HOLD)</sub>	Sample capacitor hold time		15	ns
t <sub>pd1</sub>	CONVST low to BUSY high		40	ns
t <sub>pd2</sub>	Propagation delay time, end of conversion to BUSY low		15	ns
t <sub>pd3</sub>	Propagation delay time, start of convert state to rising edge of BUSY		25	ns
t <sub>w1</sub>	Pulse duration, CONVST low	40		ns
t <sub>su1</sub>	Setup time, $\overline{\text{CS}}$ low to $\overline{\text{CONVST}}$ low	20		ns
t <sub>w2</sub>	Pulse duration, CONVST high	20		ns
	CONVST falling edge jitter		10	ps
t <sub>w3</sub>	Pulse duration, BUSY signal low	t <sub>(ACQ)</sub> min		ns
t <sub>w4</sub>	Pulse duration, BUSY signal high		610	ns
t <sub>h1</sub>	Hold time, first data bus transition (RD low, or CS low for read cycle, or BYTE or BUS18/16 input changes) after CONVST low	40		ns
t <sub>d1</sub>	Delay time, $\overline{\text{CS}}$ low to $\overline{\text{RD}}$ low	0		ns
t <sub>su2</sub>	Setup time, RD high to CS high	0		ns
t <sub>w5</sub>	Pulse duration, RD low	50		ns
t <sub>en</sub>	Enable time, $\overline{\text{RD}}$ low (or $\overline{\text{CS}}$ low for read cycle) to data valid		30	ns
t <sub>d2</sub>	Delay time, data hold from RD high	5		ns
t <sub>d3</sub>	Delay time, BUS18/16 or BYTE rising edge or falling edge to data valid	10	30	ns
t <sub>w6</sub>	Pulse duration, RD high	20		ns
t <sub>w7</sub>	Pulse duration, CS high	20		ns
t <sub>h2</sub>	Hold time, last $\overline{\text{RD}}$ (or $\overline{\text{CS}}$ for read cycle ) rising edge to $\overline{\text{CONVST}}$ falling edge	50		ns
t <sub>pd4</sub>	Propagation delay time, BUSY falling edge to next $\overline{RD}$ (or $\overline{CS}$ for read cycle) falling edge	0		ns
t <sub>d4</sub>	Delay time, BYTE edge to BUS18/16 edge skew	0		ns
t <sub>su3</sub>	Setup time, BYTE or BUS18/16 transition to RD falling edge	10		ns
t <sub>h3</sub>	Hold time, BYTE or BUS18/16 transition to RD falling edge	10		ns
t <sub>dis</sub>	Disable time, RD high (CS high for read cycle) to 3-stated data bus		30	ns
t <sub>d5</sub>	Delay time, BUSY low to MSB data valid delay		C	ns
t <sub>d6</sub>	Delay time, CS rising edge to BUSY falling edge	50		ns
t <sub>d7</sub>	Delay time, BUSY falling edge to CS rising edge	50		ns
t <sub>su5</sub>	BYTE transition setup time, from BYTE transition to next BYTE transition, or BUS18/16 transition setup time, from BUS18/16 to next BUS18/16.	50		ns
t <sub>su(ABORT)</sub>	Setup time from the falling edge of $\overline{CONVST}$ (used to start the valid conversion) to the next falling edge of $\overline{CONVST}$ (when $\overline{CS}$ is used to abort).	70	480	ns

<sup>(1)</sup> All input signals are specified with t<sub>r</sub> = t<sub>f</sub> = 5 ns (10% to 90% of +VBD) and timed from a voltage level of (V<sub>IL</sub> + V<sub>IH</sub>)/2. (2) See timing diagrams.

<sup>(2)</sup> All timing are measured with 20-pF equivalent loads on all data bits and BUSY pins.

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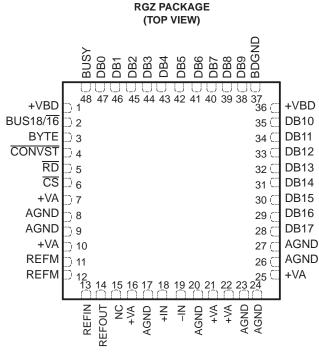
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#### **PIN ASSIGNMENTS**



NC - No internal connection

NOTE: The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

## **TERMINAL FUNCTIONS**

NAME	NO	I/O		DESCRIPTION						
AGND	8, 9, 17, 20, 23, 24, 26, 27	-	Analog ground	nalog ground						
BDGND	37	-	Digital ground for bu	s interface digital sup	ply					
BUSY	48	0	Status output. High v	when a conversion is	in progress.					
BUS18/16	2	I	Data bits output o     Last two data bits     a) the low byte pin	ze select input. Used for selecting 18-bit or 16-bit wide bus transfer. a bits output on the 18-bit data bus pins DB[17:0]. two data bits D[1:0] from 18-bit wide bus output on: e low byte pins DB[9:2] if BYTE = 0 e high byte pins DB[17:10] if BYTE = 1						
BYTE	3	I	0: No fold back	elect input. Used for 8-bit bus reading. fold back / byte D[9:2] of the 16 most significant bits is folded back to high byte of the 16 most significant pins DB[17:10].						
CONVST	4	ı	Convert start. The fa	overt start. The falling edge of this input ends the acquisition period and starts the hold period.						
CS	6	I	Chip select. The falli	ng edge of this input	starts the acquisition	period.				
				8-BIT BUS		16-BI	T BUS	18-BIT BUS		
Data Bus			BYTE = 0	BYTE = 1	BYTE = 1	BYTE = 0	BYTE = 0	BYTE = 0		
			BUS18/16 = 0	BUS18/16 = 0	BUS18/ <del>16</del> = 1	BUS18/16 = 0	BUS18/16 = 1	BUS18/16 = 0		
DB17	28	0	D17 (MSB)	D9	All ones	D17 (MSB)	All ones	D17 (MSB)		
DB16	29	0	D16	D8	All ones	D16	All ones	D16		
DB15	30	0	D15	D7	All ones	D15	All ones	D15		
DB14	31	0	D14	D6	All ones	D14	All ones	D14		
DB13	32	0	D13	D5	All ones	D13	All ones	D13		
DB12	33	0	D12	D4	All ones	D12	All ones	D12		
DB11	34	0	D11	D3	D1	D11	All ones	D11		
DB10	35	0	D10	D2	D0 (LSB)	D10	All ones	D10		

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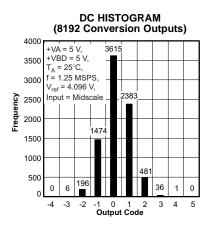
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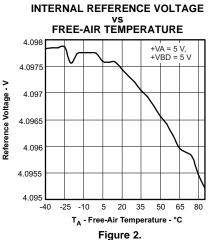
#### **TERMINAL FUNCTIONS (continued)**

NAME	NO	I/O		DESCRIPTION					
DB9	38	0	D9	All ones	All ones	D9	All ones	D9	
DB8	39	0	D8	All ones	All ones	D8	All ones	D8	
DB7	40	0	D7	All ones	All ones	D7	All ones	D7	
DB6	41	0	D6	All ones	All ones	D6	All ones	D6	
DB5	42	0	D5	All ones	All ones	D5	All ones	D5	
DB4	43	0	D4	All ones	All ones	D4	All ones	D4	
DB3	44	0	D3	All ones	All ones	D3	D1	D3	
DB2	45	0	D2	All ones	All ones	D2	D0 (LSB)	D2	
DB1	46	0	D1	All ones	All ones	D1	All ones	D1	
DB0	47	0	D0 (LSB)	All ones	All ones	D0 (LSB)	All ones	D0 (LSB)	
-IN	19	I	Inverting input chann	el					
+IN	18	I	Noninverting input ch	annel					
NC	15		No connection						
REFIN	13	I	Reference input						
REFOUT	14	0	Reference output. Ad	d 1-μF capacitor bet	ween the REFOUT p	oin and REFM pin w	hen internal referen	ce is used.	
REFM	11, 12	I	Reference ground						
RD	5	I		Synchronization pulse for the parallel output. When $\overline{ extstyle CS}$ is low, this serves as output enable and puts the previous conversion results on the bus.					
+VA	7, 10, 16, 21, 22, 25	-	Analog power supplied	Analog power supplies, 5-V DC					
+VBD	1, 36	-	Digital power supply for bus						

#### TYPICAL CHARACTERISTICS







SUPPLY VOLTAGE

4.09719

4.09718

4.09717

4.09716

4.09714

4.09713

4.75

4.85

4.95

5.05

5.15

5.25

INTERNAL REFERENCE VOLTAGE

Supply Voltage - V Figure 3.

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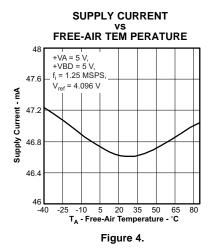
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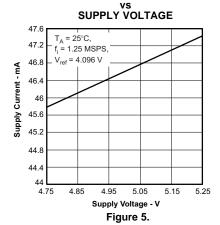
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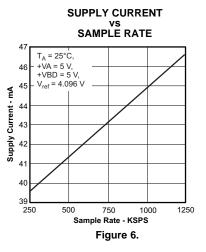


#### TYPICAL CHARACTERISTICS (continued)

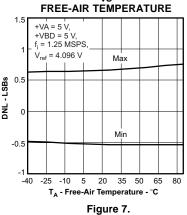
SUPPLY CURRENT



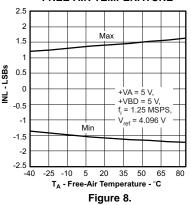




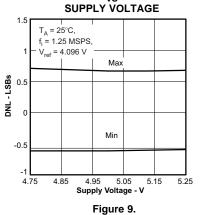
DIFFERENTIAL NONLINEARITY



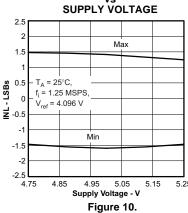




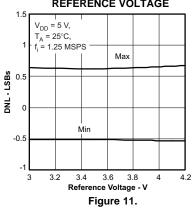
**DIFFERENTIAL NONLINEARITY** 



INTEGRAL NONLINEARITY vs SUPPLY VOLTAGE

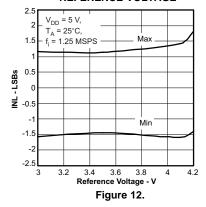


**DIFFERENTIAL NONLINEARITY** vs REFERENCE VOLTAGE



Product Folder Link(s): ADS8484

INTEGRAL NONLINEARITY vs REFERENCE VOLTAGE



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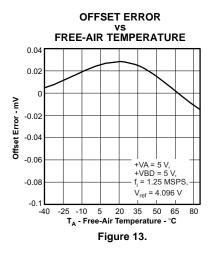
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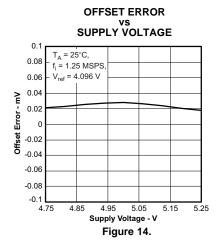
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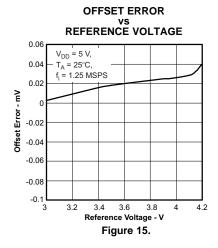
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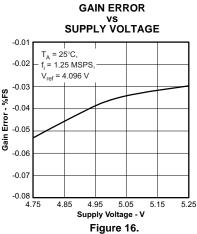
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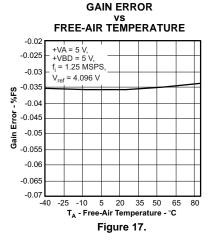
## **TYPICAL CHARACTERISTICS (continued)**

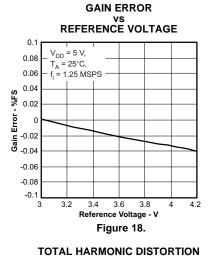


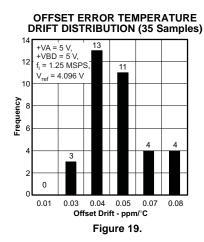


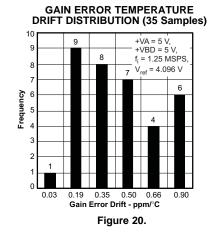


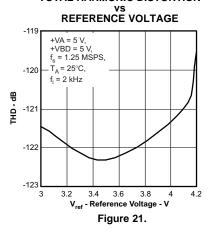












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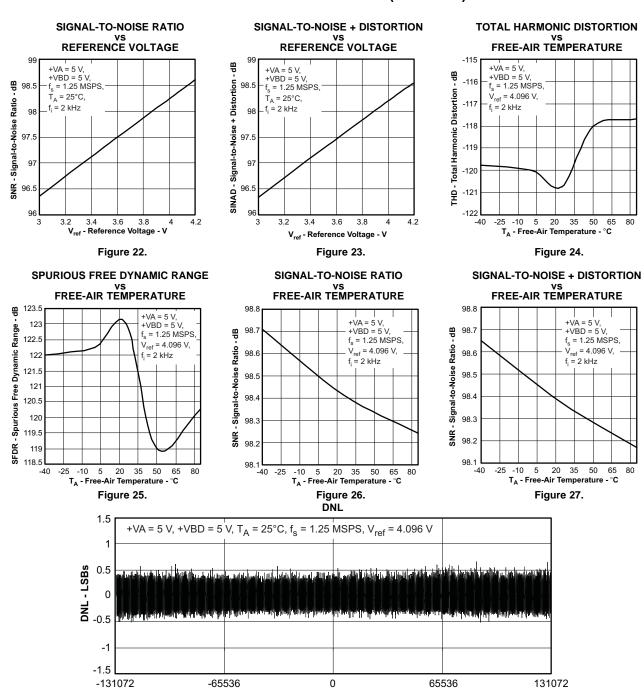
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## **TYPICAL CHARACTERISTICS (continued)**



Output Code Figure 28.

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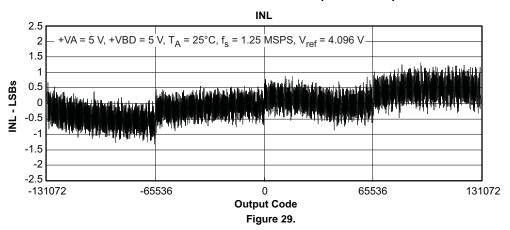
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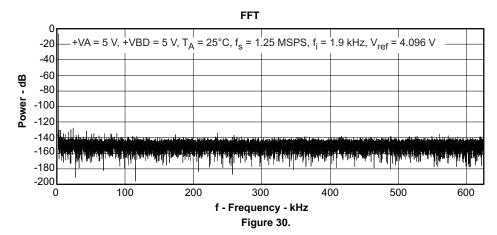


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## **TYPICAL CHARACTERISTICS (continued)**





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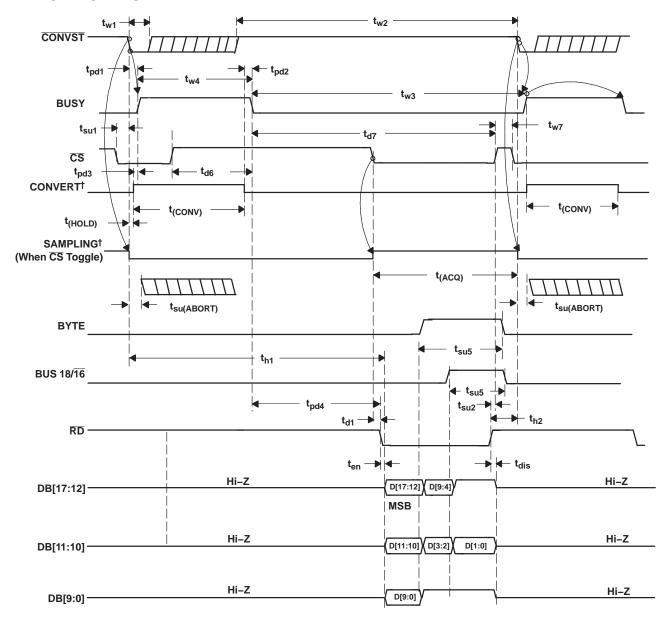
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#### **TYPICAL CHARACTERISTICS (continued)**

#### **TIMING DIAGRAMS**



†Signal internal to device

Figure 31. Timing for Conversion and Acquisition Cycles With CS and RD Toggling

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#### **TYPICAL CHARACTERISTICS (continued)**

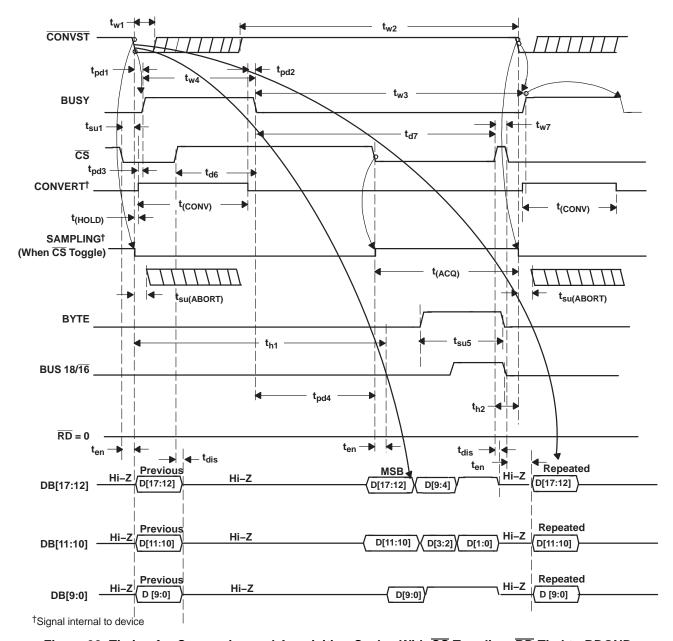


Figure 32. Timing for Conversion and Acquisition Cycles With  $\overline{\text{CS}}$  Toggling,  $\overline{\text{RD}}$  Tied to BDGND

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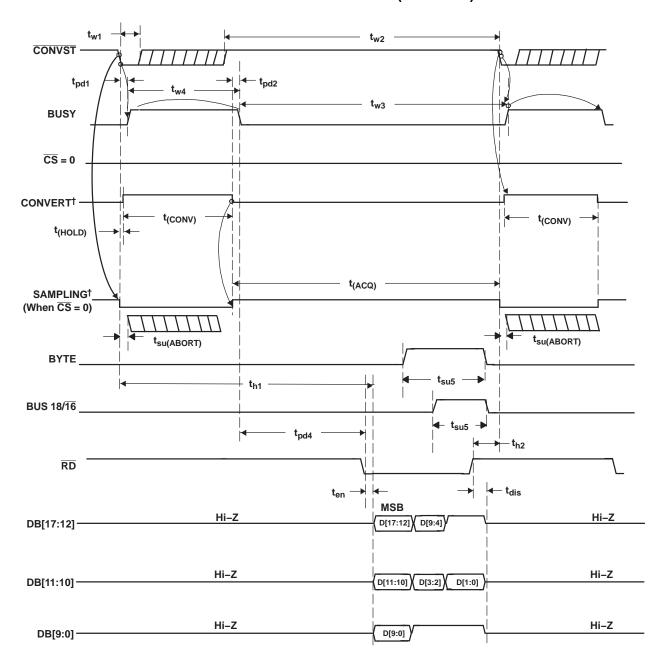
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#### **TYPICAL CHARACTERISTICS (continued)**



<sup>†</sup>Signal internal to device

Figure 33. Timing for Conversion and Acquisition Cycles With CS Tied to BDGND, RD Toggling

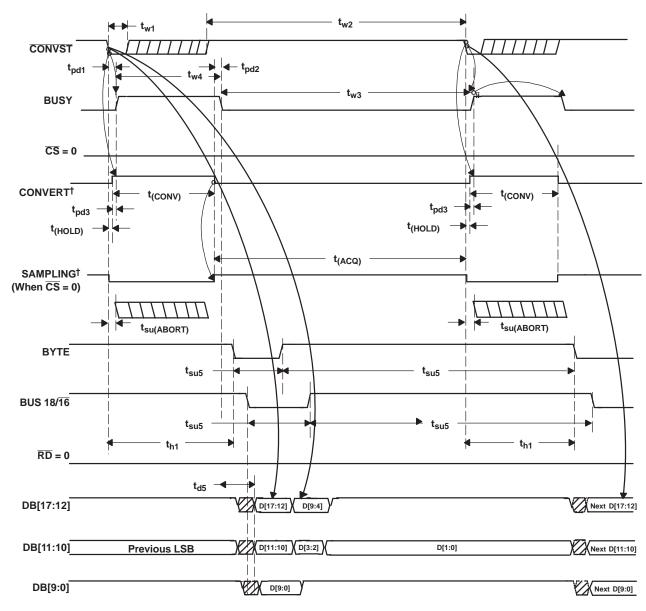
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## **TYPICAL CHARACTERISTICS (continued)**



†Signal internal to device

Figure 34. Timing for Conversion and Acquisition Cycles With  $\overline{\text{CS}}$  and  $\overline{\text{RD}}$  Tied to BDGND - Auto Read

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## **TYPICAL CHARACTERISTICS (continued)**

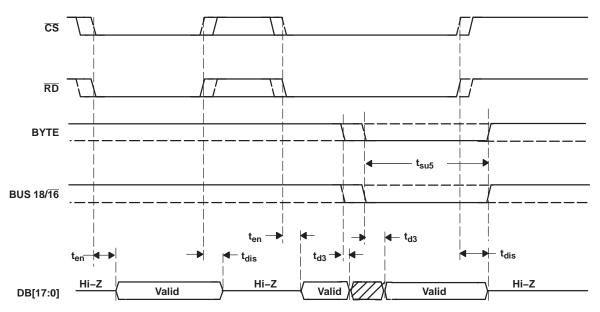


Figure 35. Detailed Timing for Read Cycles

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#### APPLICATION INFORMATION

#### MICROCONTROLLER INTERFACING

#### **ADS8484 to 8-Bit Microcontroller Interface**

Figure 36 shows a parallel interface between the ADS8484 and a typical microcontroller using the 8-bit data bus. The BUSY signal is used as a falling-edge interrupt to the microcontroller.

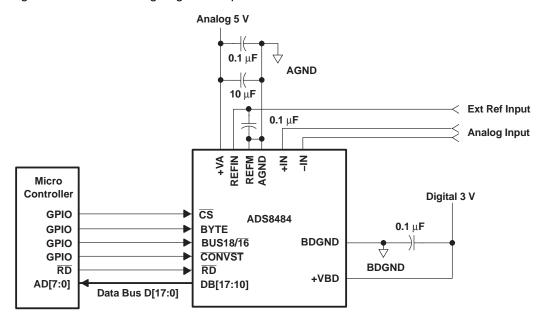


Figure 36. ADS8484 Application Circuitry

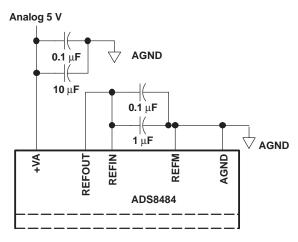


Figure 37. ADS8484 Using Internal Reference

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#### PRINCIPLES OF OPERATION

The ADS8484 is a high-speed successive approximation register (SAR) analog-to-digital converter (ADC). The architecture is based on charge redistribution which inherently includes a sample/hold function. See Figure 36 for the application circuit for the ADS8484.

The conversion clock is generated internally. The conversion time of 610 ns is capable of sustaining a 1.25-MHz throughput.

The analog input is provided to two input pins: +IN and -IN. When a conversion is initiated, the differential input on these pins is sampled on the internal capacitor array. While a conversion is in progress, both inputs are disconnected from any internal function.

#### REFERENCE

The ADS8484 can operate with an external reference with a range from 3.0 V to 4.2 V. The reference voltage on the input pin 13 (REFIN) of the converter is internally buffered. A clean, low noise, well-decoupled reference voltage on this pin is required to ensure good performance of the converter. A low noise band-gap reference like the REF3240 can be used to drive this pin. A 0.1- $\mu$ F decoupling capacitor is required between REFIN and REFM pins (pin 13 and pin 12) of the converter. This capacitor should be placed as close as possible to the pins of the device. Designers should strive to minimize the routing length of the traces that connect the terminals of the capacitor to the pins of the converter. An RC network can also be used to filter the reference voltage. A 100- $\Omega$  series resistor and a 0.1- $\mu$ F capacitor, which can also serve as the decoupling capacitor can be used to filter the reference voltage.

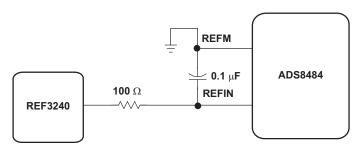


Figure 38. ADS8484 Using External Reference

The ADS8484 also has limited low pass filtering capability built into the converter. The equivalent circuitry on the REFIN input ia as shown in Figure 39.

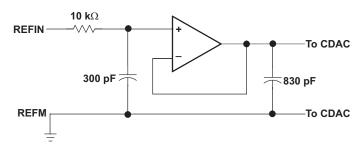


Figure 39. Simplified Reference Input Circuit

The REFM input of the ADS8484 should always be shorted to AGND. A 4.096-V internal reference is included. When internal reference is used, pin 14 (REFOUT) is connected to pin 13 (REFIN) with an 0.1- $\mu$ F decoupling capacitor and 1- $\mu$ F storage capacitor between pin 14 (REFOUT) and pins 11 and 12 (REFM) (see Figure 37). The internal reference of the converter is double buffered. If an external reference is used, the second buffer provides isolation between the external reference and the CDAC. This buffer is also used to recharge all of the capacitors of the CDAC during conversion. Pin 14 (REFOUT) can be left unconnected (floating) if external reference is used.

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#### **ANALOG INPUT**

When the converter enters the hold mode, the voltage difference between the +IN and -IN inputs is captured on the internal capacitor array. Both +IN and -IN input has a range of -0.2 V to  $V_{ref}$  + 0.2 V. The input span [+IN - (-IN)] is limited to  $-V_{ref}$  to  $V_{ref}$ .

The input current on the analog inputs depends upon a number of factors: sample rate, input voltage, and source impedance. Essentially, the current into the ADS8484 charges the internal capacitor array during the sample period. After this capacitance has been fully charged, there is no further input current. The source of the analog input must be able to charge the input capacitance (65 pF) to an 18-bit settling level within the acquisition time (175 ns) of the device. When the converter goes into the hold mode, the input impedance is greater than 1  $G\Omega$ .

Care must be taken regarding the absolute analog input voltage. To maintain the linearity of the converter, the +IN and -IN inputs and the span [+IN - (-IN)] must be within the limits specified. Outside of these ranges, the converter's linearity may not meet specifications. To minimize noise, low bandwidth input signals with low-pass filters are used.

Care must be taken to ensure that the output impedance of the sources driving the +IN and -IN inputs are matched. If this is not observed, the two inputs could have different setting times. This may result in offset error, gain error, and linearity error which varies with temperature and input voltage.

The analog input to the converter needs to be driven with a low noise, high-speed op-amp like the THS4031. An RC filter is recommended at the input pins to low-pass filter the noise from the source. The input to the converter is a uni-polar input voltage in the range 0 to  $V_{ref}$ . The THS4031 can be used in the source follower configuration to drive the converter.

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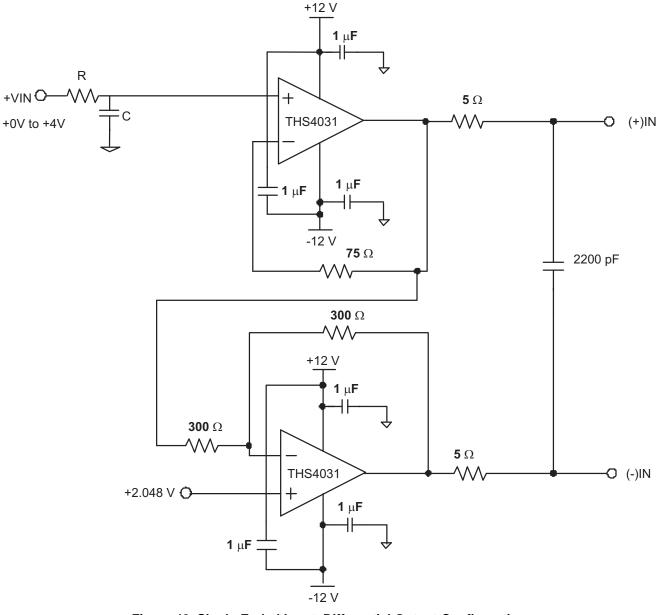


Figure 40. Single-Ended Input, Differential Output Configuration

In systems, where the input is differential, the THS4031 can be used in the inverting configuration with an additional DC bias applied to its + input so as to keep the input to the ADS8484 within its rated operating voltage range. The DC bias can be derived from the REF3220 or the REF3240 reference voltage ICs. The input configuration shown below is capable of delivering better than 97dB SNR and -103db THD at an input frequency of 100 kHz. In case band-pass filters are used to filter the input, care should be taken to ensure that the signal swing at the input of the band-pass filter is small so as to keep the distortion introduced by the filter minimal. In such cases, the gain of the circuit shown below can be increased to keep the input to the ADS8484 large to keep the SNR of the system high. Note that the gain of the system from the + input to the output of the THS4031 in such a configuration is a function of the gain of the AC signal. A resistor divider can be used to scale the output of the REF3220 or REF3240 to reduce the voltage at the DC input to THS4031 to keep the voltage at the input of the converter within its rated operating range.

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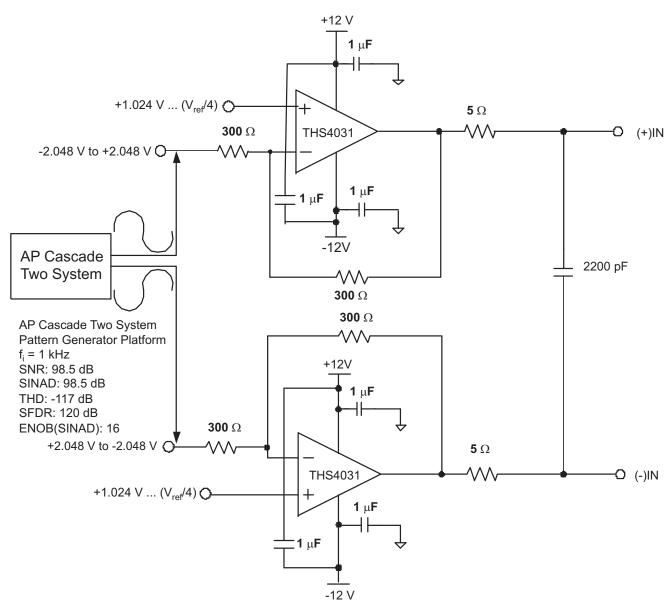


Figure 41. Differential Input, Differential Output Configuration

#### **DIGITAL INTERFACE**

#### **Timing and Control**

See the timing diagrams in the specifications section for detailed information on timing signals and their requirements.

The ADS8484 uses an internal oscillator generated clock which controls the conversion rate and in turn the throughput of the converter. No external clock input is required.

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Conversions are initiated by bringing the  $\overline{\text{CONVST}}$  pin low for a minimum of 20 ns (after the 20 ns minimum requirement has been met, the  $\overline{\text{CONVST}}$  pin can be brought high), while  $\overline{\text{CS}}$  is low. The ADS8484 switches from the sample to the hold mode on the falling edge of the  $\overline{\text{CONVST}}$  command. A clean and low jitter falling edge of this signal is important to the performance of the converter. The BUSY output is brought high immediately following  $\overline{\text{CONVST}}$  going low. BUSY stays high throughout the conversion process and returns low when the conversion has ended.

Sampling starts  $t_{pd}$  ns before the falling edge of the BUSY signal when  $\overline{CS}$  is tied low or starts with the falling edge of  $\overline{CS}$  when BUSY is low.

Both  $\overline{RD}$  and  $\overline{CS}$  can be high during and before a conversion with one exception ( $\overline{CS}$  must be low when  $\overline{CONVST}$  goes low to initiate a conversion). Both the  $\overline{RD}$  and  $\overline{CS}$  pins are brought low in order to enable the parallel output bus with the conversion.

#### **Reading Data**

The ADS8484 outputs full parallel data in two's complement format as shown in Table 1. The parallel output is active when  $\overline{\text{CS}}$  and  $\overline{\text{RD}}$  are both low. There is a minimal quiet zone requirement around the falling edge of  $\overline{\text{CONVST}}$ . This is 50 ns prior to the falling edge of  $\overline{\text{CONVST}}$  and 40 ns after the falling edge. No data read should attempted within this zone. Any other combination of  $\overline{\text{CS}}$  and  $\overline{\text{RD}}$  sets the parallel output to 3-state. BYTE and BUS18/ $\overline{16}$  are used for multiword read operations. BYTE is used whenever lower bits on the bus are output on the higher byte of the bus. BUS18/ $\overline{16}$  is used whenever the last two bits on the 18-bit bus is output on either bytes of the higher 16-bit bus. Refer to Table 1 for ideal output codes.

DESCRIPTION **ANALOG VALUE DIGITAL OUTPUT TWO'S COMPLEMENT** Full scale range  $+V_{ref}$ Least significant bit (LSB)  $2 \times (+V_{ref})/262144$ **BINARY CODE HEX CODE** +Full scale  $(+V_{ref}) - 1 LSB$ 01 1111 1111 1111 1111 1FFFF Midscale 0 V 00 0000 0000 0000 0000 00000 Midscale - 1 LSB 0 V - 1 LSB 11 1111 1111 1111 1111 3FFFF Zero 10 0000 0000 0000 0000 20000  $-V_{ref}$ 

Table 1. Ideal Input Voltages and Output Codes

The output data is a full 18-bit word (D17-D0) on DB17-DB0 pins (MSB-LSB) if both BUS18/16 and BYTE are low.

The result may also be read on an 16-bit bus by using only pins DB17–DB2. In this case two reads are necessary: the first as before, leaving both BUS18/ $\overline{16}$  and BYTE low and reading the 16 most significant bits (D17–D2) on pins DB17–DB2, then bringing BUS18/ $\overline{16}$  high while holding BYTE low. When BUS18/ $\overline{16}$  is high, the lower two bits (D1–D0) appear on pins DB3–DB2.

The result may also be read on an 8-bit bus for convenience. This is done by using only pins DB17–DB10. In this case three reads are necessary: the first as before, leaving both BUS18/16 and BYTE low and reading the 8 most significant bits on pins DB17–DB10, then bringing BYTE high while holding BUS18/16 low. When BYTE is high, the medium bits (D9–D2) appear on pins DB17–DB10. The last read is done by bringing BUS18/16 high while holding BYTE high. When BUS18/16 is high, the lower two bits (D1–D0) appear on pins DB11–DB10. The last read cycle is not necessary if only the first 16 most significant bits are of interest.

All of these multiword read operations can be performed with multiple active  $\overline{RD}$  (toggling) or with  $\overline{RD}$  held low for simplicity. This is referred to as the AUTO READ operation.

Table 2. Conversion Data Read Out

		DATA READ OUT							
BYTE	BUS18/16	PINS DB17-DB12	PINS DB11-DB10	PINS DB9-DB4	PINS DB3-DB2	PINS DB1-DB0			
High	High	All One's	D1-D0	All One's	All One's	All One's			
Low	High	All One's	All One's	All One's	D1-D0	All One's			
High	Low	D9-D4	D3-D2	All One's	All One's	All One's			
Low	Low	D17-D12	D11-D10	D9-D4	D3-D2	D1-D0			

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#### RESET

On power-up, internal POWER-ON RESET circuitry generates the reset required for the device. The first three conversions after power-up are used to load factory trimming data for a specific device to assure high accuracy of the converter. The results of the first three conversions are invalid and should be discarded.

The device can also be reset through the use of the combination fo  $\overline{\text{CS}}$  and  $\overline{\text{CONVST}}$ . Since the BUSY signal is held at high during the conversion, either one of these conditions triggers an internal self-clear reset to the converter.

- Issue a CONVST when CS is low and the internal convert state is high. The falling edge of CONVST starts a
  reset.
- Issue a S (select the device) while the internal convert state is high. The falling edge of s causes a reset.

Once the device is reset, all output latches are cleared (set to zeroes) and the BUSY signal is brought low. A new sampling period is started at the falling edge of the BUSY signal immediately after the instant of the internal reset.

#### **LAYOUT**

For optimum performance, care must be taken with the physical layout of the ADS8484 circuitry.

As the ADS8484 offers single-supply operation, it is often used in close proximity with digital logic, microcontrollers, microprocessors, and digital signal processors. The more digital logic present in the design and the higher the switching speed, the more difficult it is to achieve good performance from the converter.

The basic SAR architecture is sensitive to glitches or sudden changes on the power supply, reference, ground connections and digital inputs that occur just prior to latching the output of the analog comparator. Thus, driving any single conversion for an n-bit SAR converter, there are at least n windows in which large external transient voltages can affect the conversion result. Such glitches might originate from switching power supplies, nearby digital logic, or high power devices.

The degree of error in the digital output depends on the reference voltage, layout, and the exact timing of the external event.

On average, the ADS8484 draws very little current from an external reference as the reference voltage is internally buffered. If the reference voltage is external and originates from an op amp, make sure that it can drive the bypass capacitor or capacitors without oscillation. A 0.1-µF capacitor is recommended from pin 13 (REFIN) directly to pin 12 (REFM). REFM and AGND must be shorted on the same ground plane under the device.

The AGND and BDGND pins should be connected to a clean ground point. In all cases, this should be the analog ground. Avoid connections which are too close to the grounding point of a microcontroller or digital signal processor. If required, run a ground trace directly from the converter to the power supply entry point. The ideal layout consists of an analog ground plane dedicated to the converter and associated analog circuitry.

As with the AGND connections, +VA should be connected to a 5-V power supply plane or trace that is separate from the connection for digital logic until they are connected at the power entry point. Power to the ADS8484 should be clean and well bypassed. A 0.1- $\mu$ F ceramic bypass capacitor should be placed as close to the device as possible. See Table 3 for the placement of the capacitor. In addition, a 1- $\mu$ F to 10- $\mu$ F capacitor is recommended. In some situations, additional bypassing may be required, such as a 100- $\mu$ F electrolytic capacitor or even a Pi filter made up of inductors and capacitors-all designed to essentially low-pass filter the 5-V supply, removing the high frequency noise.

**Table 3. Power Supply Decoupling Capacitor Placement** 

POWER SUPPLY PLANE	CONVERTER ANALOG SIDE	CONVERTER	
SUPPLY PINS	CONVERTER ANALOG SIDE	DIGITAL SIDE	
Pin pairs that require shortest path to decoupling capacitors	(7,8), (9,10), (16,17), (20,21), (22,23), (25,26)	(36,37)	
Pins that require no decoupling	24, 26	1	



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PACKAGE OPTION ADDENDUM

24-Sep-2015

#### PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package	Pins I	Package	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
ADS8484IBRGZT	ACTIVE	VQFN	RGZ	48	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	ADS8484I B	Samples
ADS8484IRGZT	ACTIVE	VQFN	RGZ	48	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	ADS8484I	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design. PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): Tl's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between

the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "-" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width

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PACKAGE OPTION ADDENDUM

24-Sep-2015

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

Addendum-Page 2

Datasheet of ADS8484IBRGZT - IC ADC 18BIT 1.25MSPS 48-VQFN

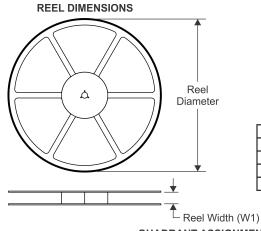
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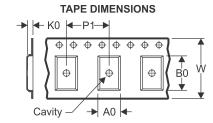


## **PACKAGE MATERIALS INFORMATION**

www.ti.com 2-Sep-2015

#### TAPE AND REEL INFORMATION



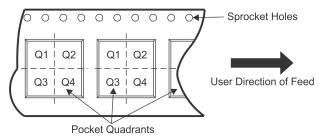


	Dimension designed to accommodate the component width
	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness

W Overall width of the carrier tape

P1 Pitch between successive cavity centers

#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

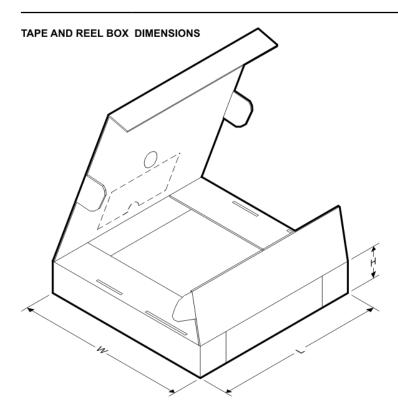
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
ADS8484IBRGZT	VQFN	RGZ	48	250	180.0	16.4	7.3	7.3	1.5	12.0	16.0	Q2
ADS8484IRGZT	VQFN	RGZ	48	250	180.0	16.4	7.3	7.3	1.5	12.0	16.0	Q2

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## **PACKAGE MATERIALS INFORMATION**

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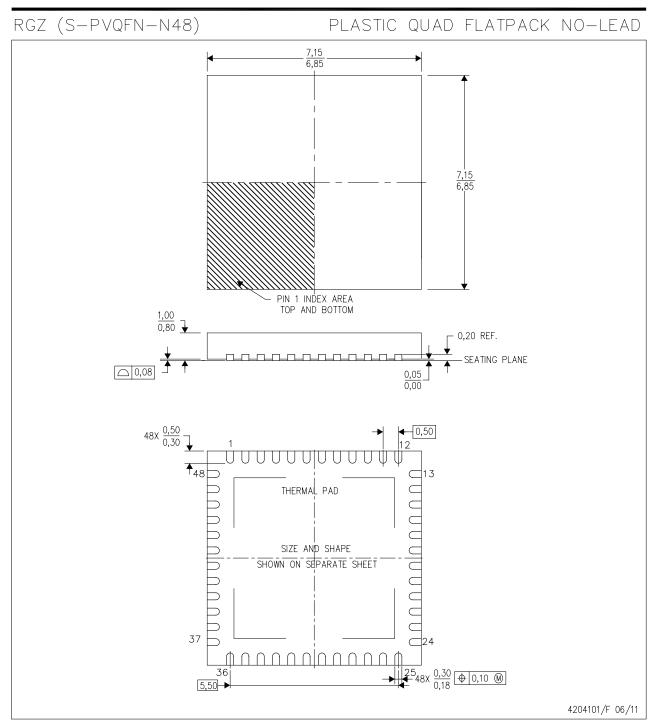


#### \*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
ADS8484IBRGZT	VQFN	RGZ	48	250	213.0	191.0	55.0
ADS8484IRGZT	VQFN	RGZ	48	250	213.0	191.0	55.0



## **MECHANICAL DATA**



- NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M—1994.
  - B. This drawing is subject to change without notice.
  - C. Quad Flatpack, No-leads (QFN) package configuration.
  - D. The package thermal pad must be soldered to the board for thermal and mechanical performance.
  - E. See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.
  - F. Falls within JEDEC MO-220.





## THERMAL PAD MECHANICAL DATA

## RGZ (S-PVQFN-N48)

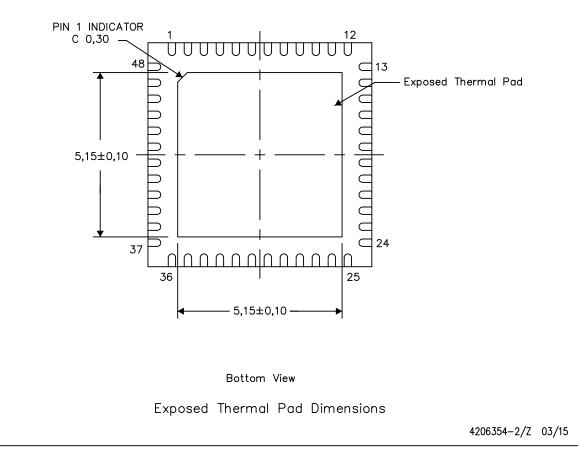
## PLASTIC QUAD FLATPACK NO-LEAD

#### THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No—Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



NOTE: All linear dimensions are in millimeters



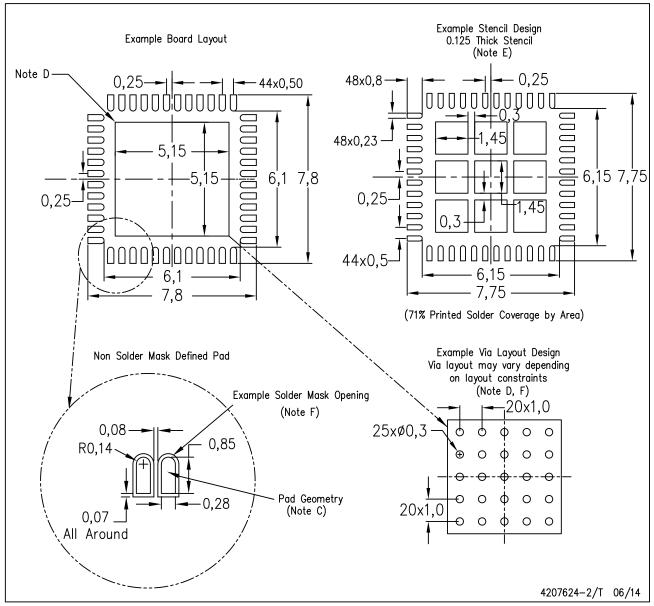




#### LAND PATTERN DATA

RGZ (S-PVQFN-N48)

PLASTIC QUAD FLATPACK NO-LEAD



#### NOTES:

- A. All linear dimensions are in millimeters.
- 3. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, Quad Flat—Pack Packages, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com <a href="https://www.ti.com">www.ti.com</a>.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
- F. Customers should contact their board fabrication site for recommended solder mask tolerances and via tenting recommendations for vias placed in the thermal pad.





Datasheet of ADS8484IBRGZT - IC ADC 18BIT 1.25MSPS 48-VQFN

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